



# Power MOSFETS

## DATASHEET

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**LM45013NHM8A**

N-Channel  
Enhancement Mode MOSFET

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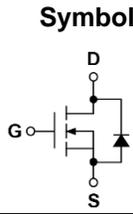
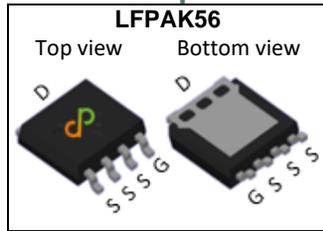


Quality Management Systems

ISO 9001:2015 Certificate

## N-Channel Enhancement Mode MOSFET

### Pin Description



### Product Summary

| Symbol           | N-Channel | Unit       |
|------------------|-----------|------------|
| $V_{DSS}$        | 45        | V          |
| $R_{DS(ON)-Max}$ | 1.1       | m $\Omega$ |
| ID               | 234       | A          |

### Feature

- Fast switching speed
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS and Rg Tested
- Moisture Sensitivity Level MSL1

### Applications

- DC-to-DC converters
- Switch Mode Power Supply
- Brushless DC motor control

### Ordering Information

| Orderable Part Number | Package Type | Form        | Shipping           | Marking         |
|-----------------------|--------------|-------------|--------------------|-----------------|
| LM45013NHM8A          | LFPACK56     | Tape & Reel | 4000 / Tape & Reel | 45013<br>□□□□□□ |

Note : □□□□□□ = Lot Code

### Absolute Maximum Ratings (T<sub>J</sub>=25°C Unless Otherwise Noted)

| Symbol                | Parameter                        | N-Channel                            | Unit |
|-----------------------|----------------------------------|--------------------------------------|------|
| $V_{DSS}$             | Drain-Source Voltage             | 45                                   | V    |
| $V_{GSS}$             | Gate-Source Voltage              | ±20                                  |      |
| $T_J$                 | Maximum Junction Temperature     | 175                                  | °C   |
| $T_{STG}$             | Storage Temperature Range        | -55 to 175                           | °C   |
| $I_S$                 | Diode Continuous Forward Current | $T_C=25^\circ C$<br>95               | A    |
| $I_{SP}$              | Diode Pulse Current              | $T_C=25^\circ C$<br>400              | A    |
| $I_{DM}$              | Pulse Drain Current Tested       | $T_C=25^\circ C$<br>585 <sup>①</sup> | A    |
| $I_D$                 | Continuous Drain Current         | $T_C=25^\circ C$<br>234              | A    |
|                       |                                  | $T_C=100^\circ C$<br>166             |      |
| $P_D$                 | Maximum Power Dissipation        | $T_C=25^\circ C$<br>125              | W    |
|                       |                                  | $T_C=100^\circ C$<br>63              |      |
| $I_D$                 | Continuous Drain Current         | $T_A=25^\circ C$<br>38.2             | A    |
|                       |                                  | $T_A=70^\circ C$<br>32               |      |
| $P_D$                 | Maximum Power Dissipation        | $T_A=25^\circ C$<br>3.3              | W    |
|                       |                                  | $T_A=70^\circ C$<br>2.3              |      |
| $I_{AS}$ <sup>②</sup> | Avalanche Current, Single pulse  | L=0.1mH<br>52                        | A    |
|                       |                                  | L=0.5mH<br>29                        |      |
| $E_{AS}$ <sup>②</sup> | Avalanche Energy, Single pulse   | L=0.1mH<br>135                       | mJ   |
|                       |                                  | L=0.5mH<br>210                       |      |

### Thermal Characteristics

| Symbol                       | Parameter                              | Rating       | Unit     |
|------------------------------|--|--------------|----------|
| $R_{\theta JC}$              | Thermal Resistance-Junction to Case    | Steady State | 1.2 °C/W |
| $R_{\theta JA}$ <sup>③</sup> | Thermal Resistance-Junction to Ambient | Steady State | 45 °C/W  |

Note ① : Max. current is limited by junction temperature

Note ② : UIS tested and pulse width are limited by maximum junction temperature 175°C

Note ③ : Surface Mounted on 1in<sup>2</sup> FR-4 board with 1oz

## N-Channel Electrical Characteristics (T<sub>J</sub>=25°C Unless Otherwise Noted)

| Symbol                                      | Parameter                        | Test Conditions  | Min. | Typ. | Max. | Unit |
|---|----------------------------------|--|------|------|------|------|
| <b>Static Electrical Characteristics</b>    |                                  |  |      |      |      |      |
| <b>BV<sub>DSS</sub></b>                     | Drain-Source Breakdown Voltage   | V <sub>GS</sub> =0V, I <sub>DS</sub> =250uA  | 45   | -    | -    | V    |
| <b>I<sub>DSS</sub></b>                      | Zero Gate Voltage Drain Current  | V <sub>DS</sub> =36V, V <sub>GS</sub> =0V  | -    | -    | 1    | uA   |
| <b>V<sub>GS(th)</sub></b>                   | Gate Threshold Voltage           | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250uA                              | 2.5  | 3    | 3.5  | V    |
| <b>I<sub>GSS</sub></b>                      | Gate Leakage Current             | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V   | -    | -    | ±100 | nA   |
| <b>R<sub>DS(ON)</sub></b> <sup>④</sup>      | Drain-Source On-state Resistance | V <sub>GS</sub> =10V, I <sub>DS</sub> =20A   | -    | 0.9  | 1.1  | mΩ   |
| <b>gfs</b>                                  | Forward Transconductance         | V <sub>DS</sub> =5V, I <sub>DS</sub> =10A  | -    | 34   | -    | S    |
| <b>Dynamic Characteristics</b> <sup>⑤</sup> |                                  |  |      |      |      |      |
| <b>R<sub>G</sub></b>                        | Gate Resistance                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, Freq.=1MHz                                   | -    | 1    | -    | Ω    |
| <b>C<sub>iss</sub></b>                      | Input Capacitance                | V <sub>GS</sub> =0V, V <sub>DS</sub> =22.5V, Freq.=1MHz                                | -    | 5236 | -    | pF   |
| <b>C<sub>oss</sub></b>                      | Output Capacitance               |  | -    | 1480 | -    |      |
| <b>C<sub>rss</sub></b>                      | Reverse Transfer Capacitance     |  | -    | 35   | -    |      |
| <b>td(ON)</b>                               | Turn-on Delay Time               | V <sub>GS</sub> =10V, V <sub>DS</sub> =22.5V, I <sub>D</sub> =1A, R <sub>GEN</sub> =1Ω | -    | 21   | -    | nS   |
| <b>t<sub>r</sub></b>                        | Turn-on Rise Time                |  | -    | 12.2 | -    |      |
| <b>t<sub>d(OFF)</sub></b>                   | Turn-off Delay Time              |  | -    | 43.6 | -    |      |
| <b>t<sub>f</sub></b>                        | Turn-off Fall Time               |  | -    | 98   | -    |      |
| <b>Q<sub>g</sub></b>                        | Total Gate Charge                | V <sub>GS</sub> =10V, V <sub>DS</sub> =22.5V, I <sub>D</sub> =20A                      | -    | 68   | -    | nC   |
| <b>Q<sub>gs</sub></b>                       | Gate-Source Charge               |  | -    | 26   | -    |      |
| <b>Q<sub>gd</sub></b>                       | Gate-Drain Charge                |  | -    | 13   | -    |      |
| <b>Source-Drain Characteristics</b>         |                                  |  |      |      |      |      |
| <b>V<sub>SD</sub></b> <sup>④</sup>          | Diode Forward Voltage            | I <sub>SD</sub> =10A, V <sub>GS</sub> =0V  | -    | 0.75 | 1.1  | V    |
| <b>t<sub>rr</sub></b>                       | Reverse Recovery Time            | I <sub>F</sub> =10A, V <sub>R</sub> =22.5V   | -    | 55   | -    | nS   |
| <b>Q<sub>rr</sub></b>                       | Reverse Recovery Charge          | dI <sub>F</sub> /dt=100A/μs  | -    | 63   | -    | nC   |

Note ④ : Pulse test (pulse width≤300us, duty cycle≤2%).

Note ⑤ : Guaranteed by design, not subject to production testing.

## N-Channel Typical Characteristics

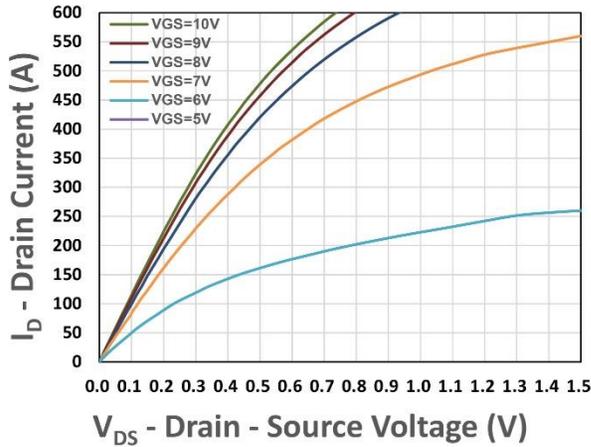


Figure 1. Output Characteristics

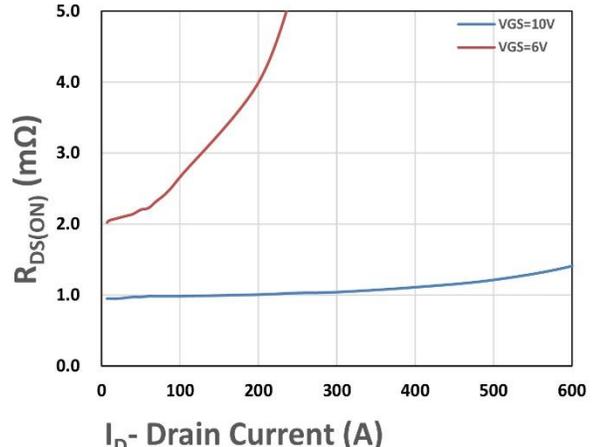


Figure 2. On-Resistance vs. ID

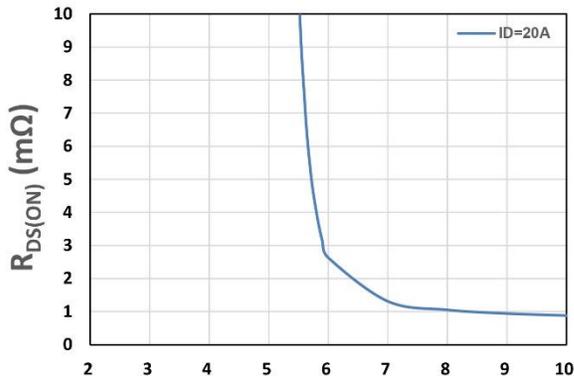


Figure 3. On-Resistance vs. VGS

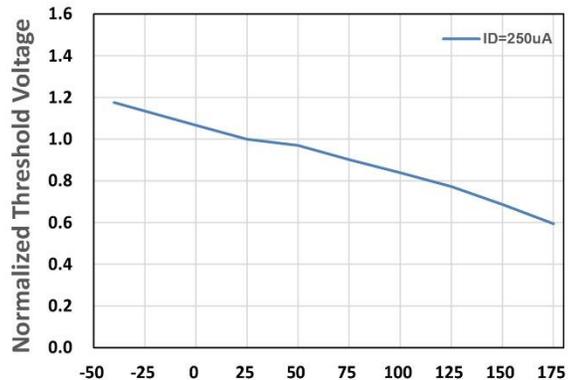


Figure 4. Gate Threshold Voltage

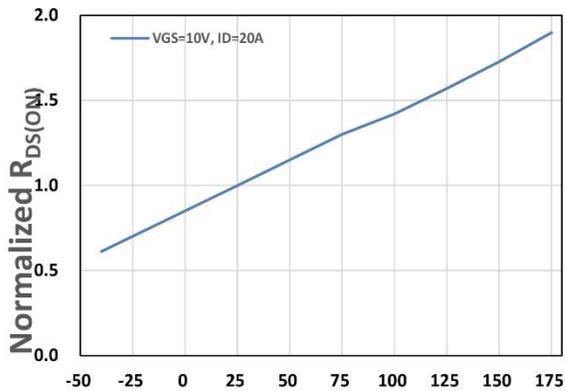


Figure 5. Drain-Source On Resistance

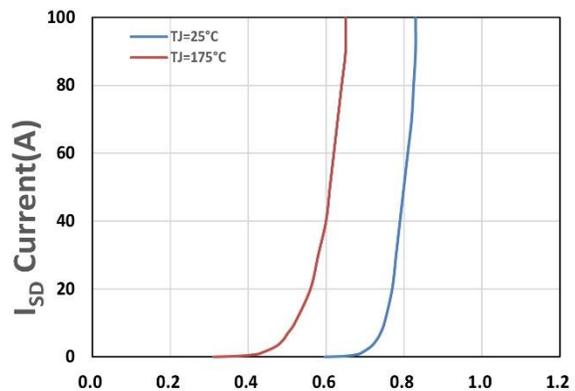
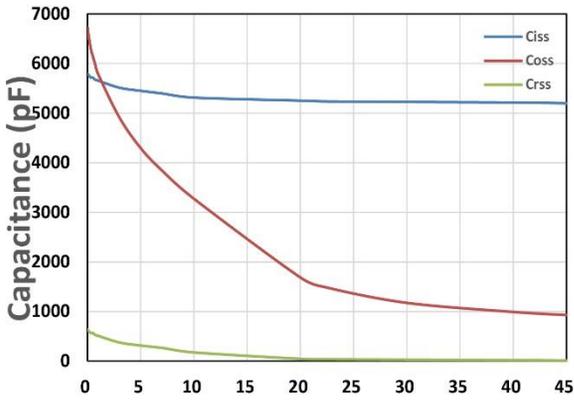
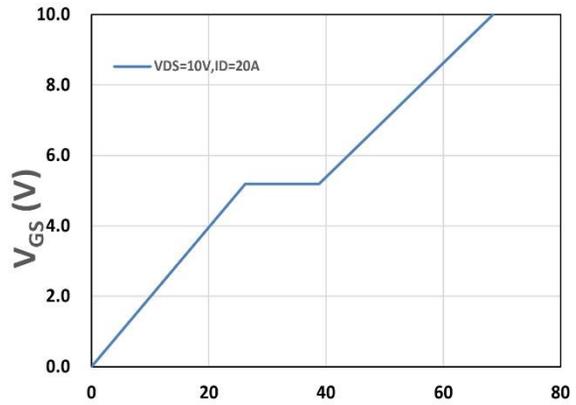


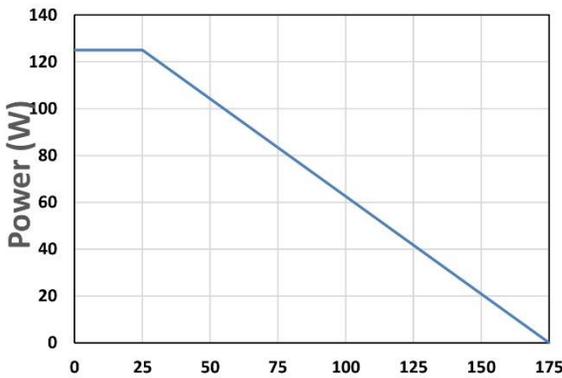
Figure 6. Source-Drain Diode Forward



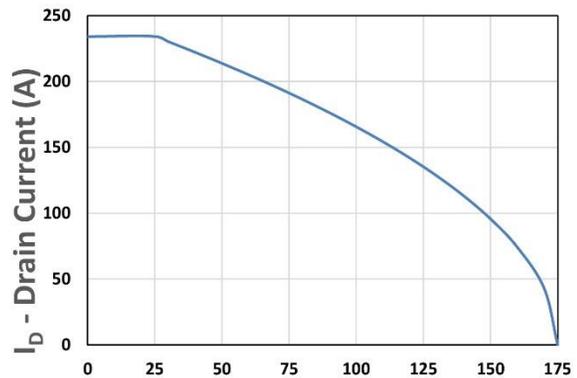
V<sub>DS</sub> - Drain - Source Voltage (V)  
Figure 7. Capacitance



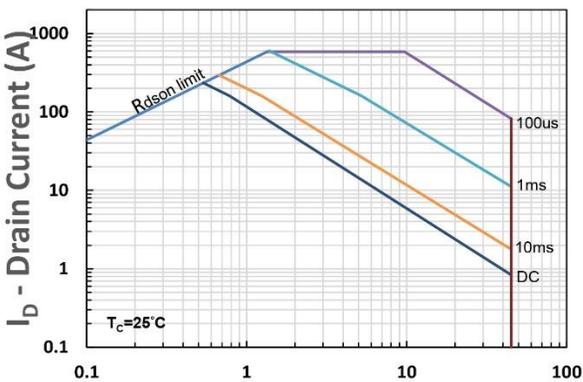
Q<sub>g</sub>, Total Gate Charge (nC)  
Figure 8. Gate Charge Characteristics



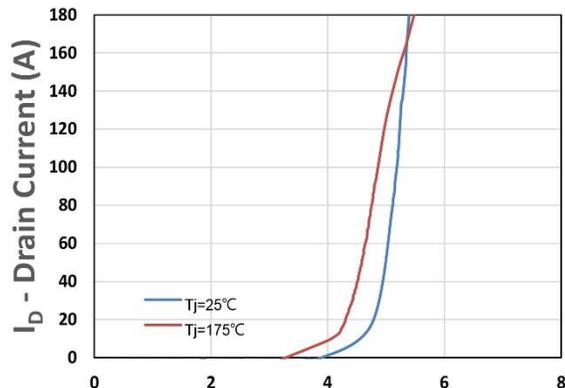
T<sub>c</sub> - Case Temperature (°C)  
Figure 9. Power Dissipation



T<sub>c</sub> - Case Temperature (°C)  
Figure 10. Drain Current



V<sub>DS</sub> - Drain-Source Voltage (V)  
Figure 11. Safe Operating Area



V<sub>GS</sub> - Gate - Source Voltage (V)  
Figure 12. Transfer Characteristics

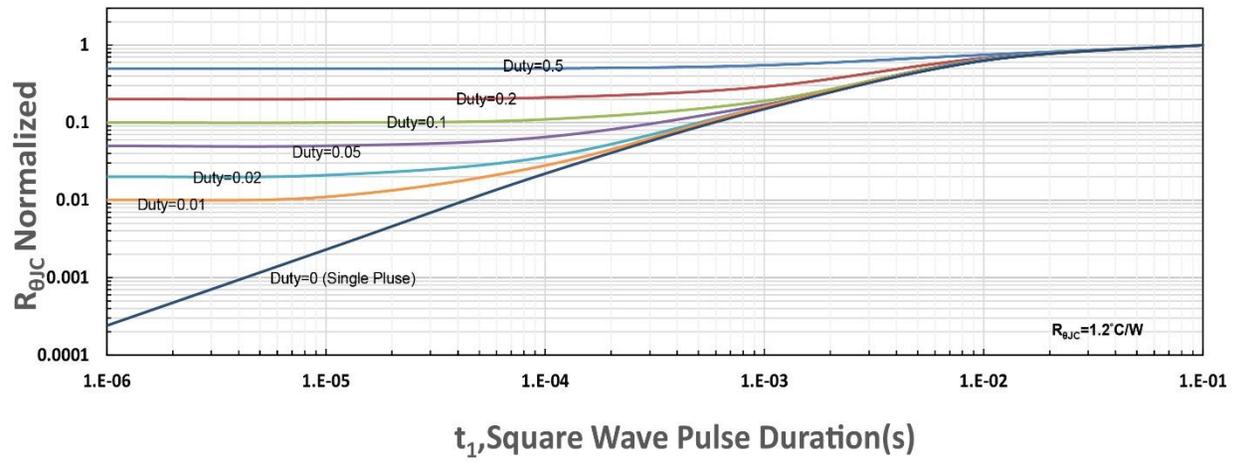


Figure 13.  $R_{\theta JC}$  Transient Thermal Impedance